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December 27, 2005

Applicant(s) : Yukihiro FURUYA et al.  
For : ROTARY RINSER

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U.S. Application No.

(if known, see 37 CFR 1.5): Unknown

Atty. Docket No.: 2138.P0043US

Mail Stop PCT  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(2) and 1.98, enclosed herewith is a copy of the International Patent Office Search Report for the foreign patent application corresponding to the present application, Form PTO-1449 and the non-U.S. references cited thereon. Copies of cited U.S. references are not submitted in accordance with 37 CFR 1.98(a).

Where necessary, the requirement for a concise explanation of relevance of any enclosed non-English reference is satisfied by the enclosed International Patent Office Search Report. Further comment at this point in time should not be necessary.

Further consideration is respectfully solicited.

Respectfully submitted,

TFC/alh

  
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Encl: Form PTO-1449 and non-U.S. references cited thereon

INFORMATION  
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CITATION

Applicant: Yukihiro FURUYA et al.

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## U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	JP 11-179314 A2	07-06-1999	Asada	Abstract
	AM	JP 2001-246342 A2	09-11-2001	Kawamuki et al.	Abstract
	AN	JP 2001-340824 A2	12-11-2001	Kawamuki et al.	Abstract
	AO				
	AP				

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	International Search Report dated October 5, 2004 (2 pages)
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED
/Jason Heckert/		07/15/2009

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.